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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/003,404	12/06/2001	Koji Nii	027260-505	5384

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EXAMINER

TRAN, TAN N

ART UNIT	PAPER NUMBER
2826	

DATE MAILED: 06/05/2002

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No.	Applicant(s)
10/003,404	NII ET AL.
Examiner	Art Unit
TAN N TRAN	2826

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --
Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).
- Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

1) Responsive to communication(s) filed on 12/06/01.
2a) This action is FINAL. 2b) This action is non-final.

3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

4) Claim(s) 1-16 is/are pending in the application.
4a) Of the above claim(s) _____ is/are withdrawn from consideration.
5) Claim(s) _____ is/are allowed.
6) Claim(s) 1-8 and 11-16 is/are rejected.
7) Claim(s) 9, 10 is/are objected to.
8) Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

9) The specification is objected to by the Examiner.
10) The drawing(s) filed on 06 December 2001 is/are: a) accepted or b) objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
11) The proposed drawing correction filed on _____ is: a) approved b) disapproved by the Examiner.
If approved, corrected drawings are required in reply to this Office action.
12) The oath or declaration is objected to by the Examiner.

Priority under 35 U.S.C. §§ 119 and 120

13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
a) All b) Some * c) None of:
1. Certified copies of the priority documents have been received.
2. Certified copies of the priority documents have been received in Application No. _____.
3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
* See the attached detailed Office action for a list of the certified copies not received.
14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).
a) The translation of the foreign language provisional application has been received.
15) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.

Attachment(s)

1) Notice of References Cited (PTO-892)
2) Notice of Draftsperson's Patent Drawing Review (PTO-948)
3) Information Disclosure Statement(s) (PTO-1449) Paper No(s) 4.

4) Interview Summary (PTO-413) Paper No(s) _____.
5) Notice of Informal Patent Application (PTO-152)
6) Other: _____

DETAILED ACTION

Specification

1. The title of the invention is not descriptive. A new title is required that is clearly indicative of the invention to which the claims are directed.

Drawings

2. The drawings are objected to under 37 CFR 1.83(a). The drawings must show every feature of the invention specified in the claims. Therefore, another gate electrode formed on the substrate through another gate insulating film, and a transistor for composing a semiconductor integrated circuit therein, wherein the film thickness of the gate insulating film is thinner than the one of the another insulating film as recited in claim 9, and the film thickness of the gate insulating film is thinner than the one of the another gate insulating film as recited in claim 15 must be shown or the feature(s) canceled from the claim(s). No new matter should be entered.

A proposed drawing correction or corrected drawings are required in reply to the Office action to avoid abandonment of the application. The objection to the drawings will not be held in abeyance.

Claim Objections

3. Claims 6 and 10 are objected to because of the following informalities:

In claim 6, lines 5 and 6, "the other diffused layer" should be changed to – said another diffused layer --.

In claim 10, line 6, "the other gate" should be changed to – said another gate --.

Appropriate correction is required.

Claim Rejections - 35 USC § 112

4. The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

Claims 4-7, 11-16 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

In claim 4, line 8, “the diffused layers” lacks of antecedent basis.

In claim 7, line 3, “the memory node” lacks of antecedent basis.

In claim 11, line 3, “the channel portion” lacks of antecedent basis.

Claim 13 is redundant of claim 7, it should depend on claim 4 instead of claim 1

Claim Rejections - 35 USC § 103

5. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

Claims 1-4, 6-8, 14 are rejected under 35 U.S.C. 103(a) as being unpatentable over Igarashi et al (6,299,314) in view of Applicant’s prior art figure 31.

With regard to claim 1, Igarashi et al. disclose a gate electrode 3 formed on a substrate 1 through a gate insulating film 2 lying therebetween; first and second diffused layers formed opposite to each other across the portion of the substrate 1 existing under the gate electrode 3 and having a first conduction type, each having a second conduction type different from the first conduction type of the portion; a contact CL12 formed within a contact hole CH12 on the substrate 1. (Note attachment # 1 of Fig. 20 of Igarashi et al.).

Igarashi et al. does not disclose a wiring layer formed above the gate electrode, so that the contact formed within a contact hole between the wiring layer and the substrate connects the wiring layer to the first diffused layer and the gate electrode.

However, Applicant' prior art discloses a wiring layer formed above the gate electrode 30, so that the contact formed within a contact hole 60 between the wiring layer and the substrate 10, which connects the wiring layer to the first diffused layer 20 and the gate electrode 30. (Note Fig. 31 of Applicant' prior art).

Therefore, it would have been obvious to one of ordinary skill in the art to form the Igarashi et al.'s device having a wiring layer formed above the gate electrode, so that the contact formed within a contact hole between the wiring layer and the substrate, which connects the wiring layer to the first diffused layer and the gate electrode such as taught by Applicant' prior art in order to connect the semiconductor device to other element or to the power supply.

With regard to claim 2, Igarashi et al. discloses the contact CL12 is connected also to the second diffused layer. (Note attachment #1 of Fig. 20 of Igarashi et al.).

With regard to claim 3, Igarashi et al. discloses a third diffused layer formed on the substrate 1; and an isolation area ST formed between the first and the third diffused layers, which

separates the first and the third diffused layers each other; wherein the contact CL12 is connected further to the third diffused layer. (Note attachment # 2 of Fig. 20 of Igarashi et al.).

With regard to claim 4, Igarashi et al. disclose a gate electrode 3 formed on a substrate 1 through a gate insulating film 2 lying therebetween; a diffused layer formed on the substrate having first and second diffused portions formed opposite to each other across the portion of the substrate 1 existing under the gate electrode 3 and having a first conduction type, each having a second conduction type different from the first conduction type of the portion of the substrate and a third portion that connects the first portion to the second portion; a contact CL12 formed within a contact hole CH12 on the substrate 1, (Note attachment # 2 of Fig. 20 of Igarashi et al.).

Igarashi et al. does not disclose a wiring layer formed above the gate electrode, so that the contact formed within a contact hole between the wiring layer and the substrate connects the wiring layer to the diffused layer and the gate electrode.

However, Applicant' prior art discloses a wiring layer formed above the gate electrode 30, so that the contact formed within a contact hole 60 between the wiring layer and the substrate 10, which connects the wiring layer to the diffused layer 20 and the gate electrode 30. (Note Fig. 31 of Applicant' prior art).

Therefore, it would have been obvious to one of ordinary skill in the art to form the Igarashi et al.'s device having a wiring layer formed above the gate electrode, so that the contact formed within a contact hole between the wiring layer and the substrate, which connects the wiring layer to diffused layer and the gate electrode such as taught by Applicant' prior art in order to connect the semiconductor device to other element or to the power supply.

With regard to claim 6, Igarashi et al. discloses another diffused layer formed on the substrate 1; and an isolation area ST formed between the first portion of the diffused layer and the another diffused layer, which separates the first portion of the diffused layer and the another diffused layer, wherein the contact is connected further to the another diffused layer. (Note attachment # 2 of Fig. 20 of Igarashi et al.).

With regard to claims 7, 8, 14 Igarashi et al. does not disclose the gate 3 is a memory node of the SRAM cell or the memory node of a bistable trigger circuit. However, it would have been obvious to one of ordinary skill in the art to form the gate 3 of Igarashi et al. functions as a memory node, because it is conventional in the art to use one of the gate electrodes that functions as a memory node. Note Fig. 1 of Sunami is cited to support for the well known position. Although Igarashi et al. and Applicant's prior art do not teach exact the type of the device as that claimed by Applicant, the type differences are considered obvious design choices and are not patentable unless unobvious or expected results are obtained from these changes. It appears that these changes produce no functional differences and therefore would have been obvious. Note in re Leshin, 125 USPQ 416.

Allowable Subject Matter

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6. Claims 5, 11, ¹²15, 16 would be allowable if rewritten to overcome the rejection(s) under 35 U.S.C. 112, second paragraph, set forth in this Office action and to include all of the limitations of the base claim and any intervening claims.

Claim 5 is allowable over the prior art of record, because none of these references disclose or can be combined to yield the claimed invention such as the contact is connected to

the first portion and the second portion of the diffused layer in claim 5, the impurity concentrations of the first diffused layer and the second diffused layer are higher than the ones of the source and the drain areas in claim 11, and the impurity concentrations of the diffused layer are higher than the impurity concentration of the source area and the drain area in claim 12, the film thickness of the gate insulating film is thinner than the one of the another gate insulating film in claim 15, the relative dielectric constant of the gate insulating film is higher than the one of the another gate insulating film in claim 16.

10. Claims 9-10 are allowable over the prior art of record because none of these references disclose or can be combined to yield the claimed invention such as the film thickness of the gate insulating film is thinner than the one of the another film in claim 9, the relative dielectric constant of the gate insulating film is higher than the one of the another gate insulating film in claim 10

Conclusion

7. Any inquiry concerning this communication or earlier communication from the examiner should be directed to Tan Tran whose telephone number is (703) 305-3362. The examiner can normally be reached on M-F 8:30AM-5PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nathan Flynn can be reached on (703) 308-6601. The fax phone numbers for the organization where this application or proceeding is assigned are (703) 308-7722 for regular communications and (703) 308-7724 for after final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.

TT

May 2002


Minh Loan Tran
Primary Examiner

FIG. 20

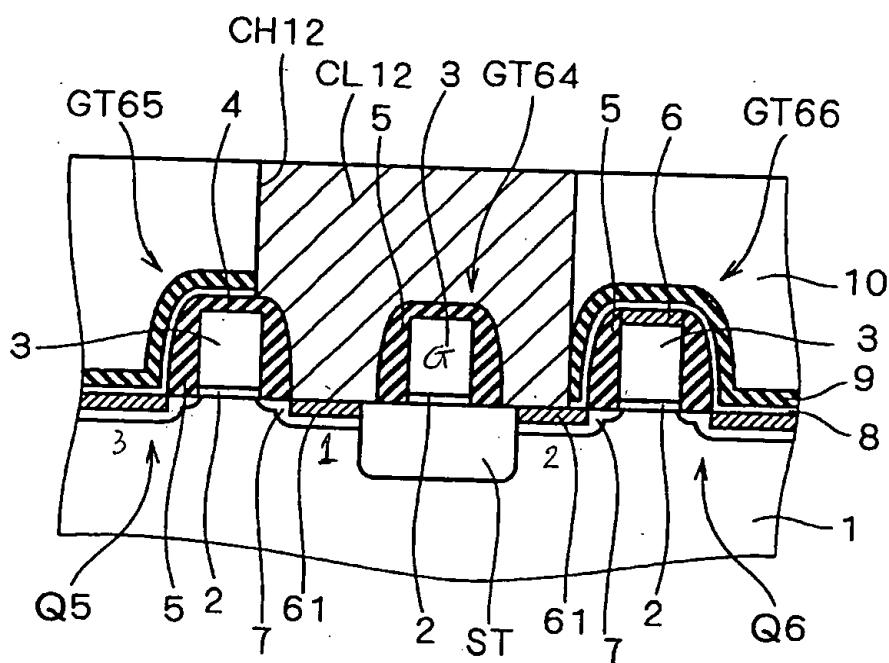
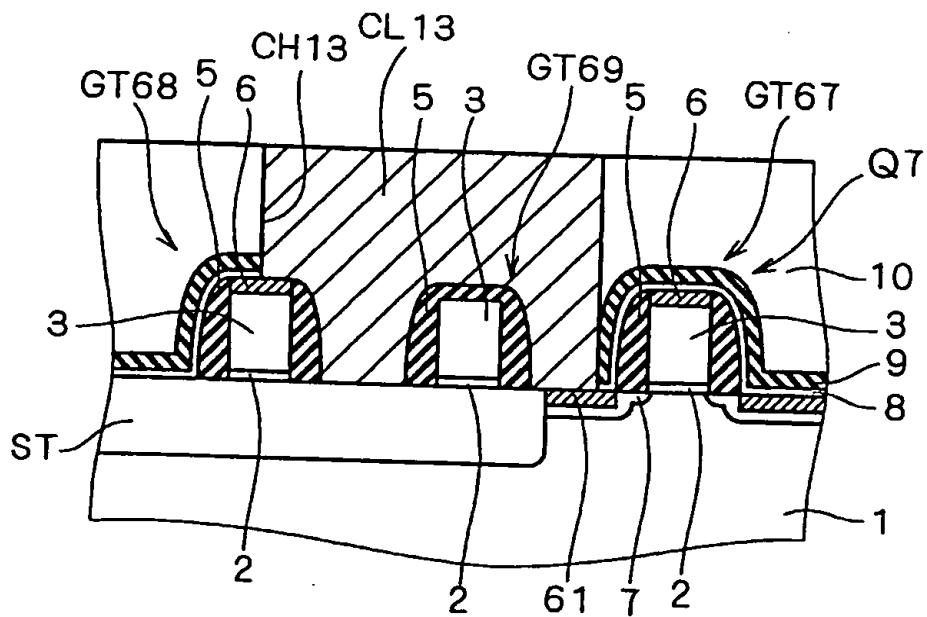
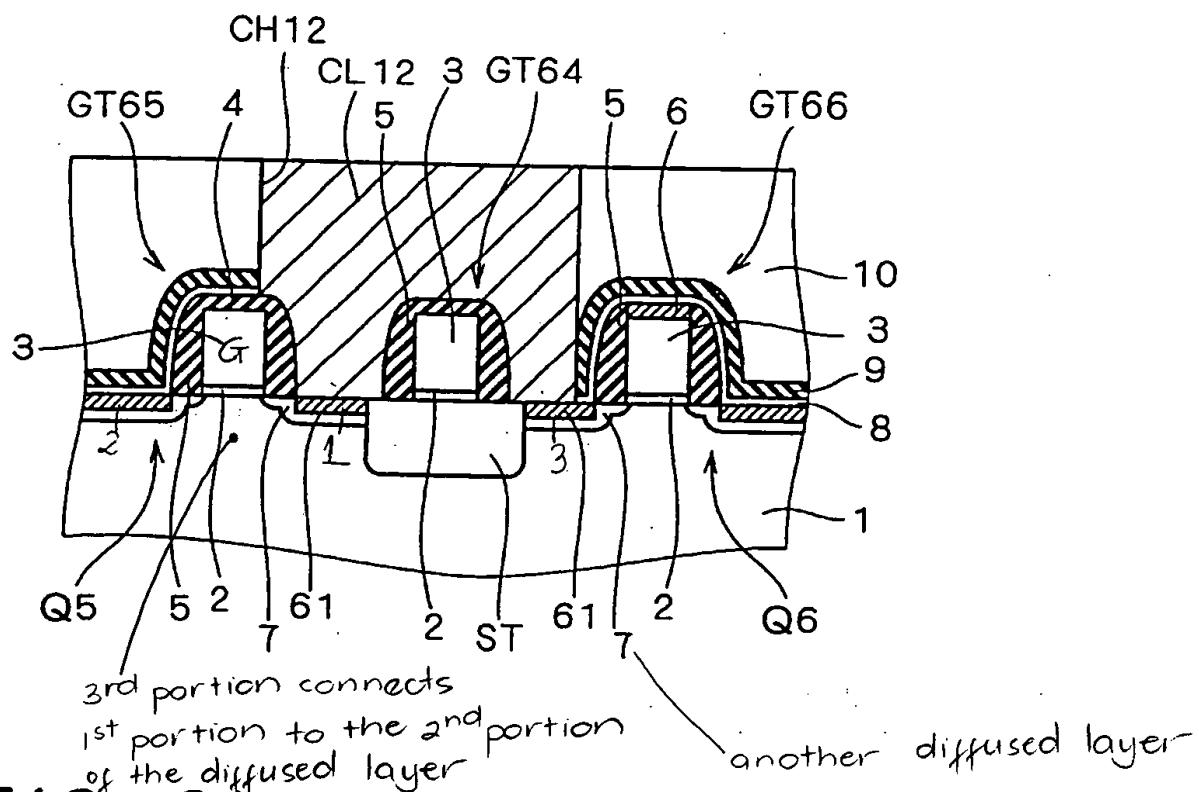


FIG. 21

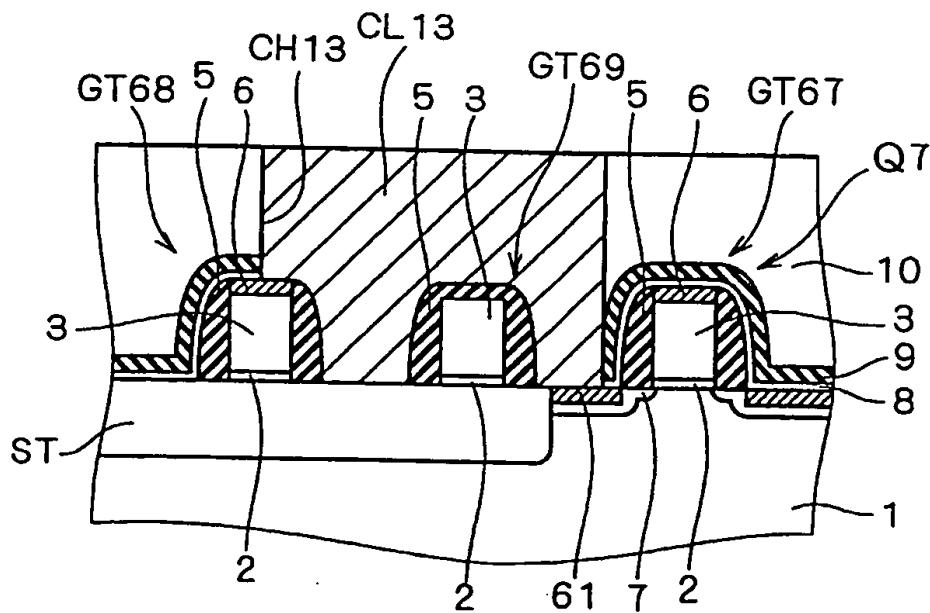


Attachment ≠ ?

FIG. 20



of the air
FIG. 21



Attachment # 2